

Search Notes	Application/Control No. 10786072- <i>P.D.</i> <i>Patrick C. Wier</i>	Applicant(s)/Patent Under Reexamination ISHII ET AL.HARJANTO, ANDY
	Examiner Darno, Patrick ADarno, Patrick A	Art Unit 21632163

SEARCHED

Class	Subclass	Date	Examiner
707	009	09/17/2007	PAD
718	104	09/17/2007	PAD
340	5.28	09/17/2007	PAD
455	410	09/17/2007	PAD
709	229	09/17/2007	PAD

SEARCH NOTES

Search Notes	Date	Examiner
EAST	09/17/2007	PAD

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner